

September 1991 Revised November 1999

74ACTQ18823 18-Bit D-Type Flip-Flop with 3-STATE Outputs

General Description

The ACTQ18823 contains eighteen non-inverting D-type flip-flops with 3-STATE outputs and is intended for bus oriented applications. The device is byte controlled. A buffered clock (CP), Clear ($\overline{\text{CLR}}$), Clock Enable ($\overline{\text{EN}}$) and Output Enable ($\overline{\text{OE}}$) are common to each byte and can be shorted together for full 18-bit operation.

The ACTQ18823 utilizes Fairchild's Quiet Series™ technology to guarantee quiet output switching and improved dynamic threshold performance. FACT Quiet Series™ features GTO™ output control and undershoot corrector for superior performance.

Features

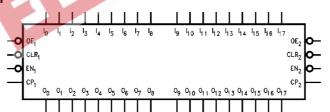
- Utilizes Fairchild's FACT Quiet Series technology
- Broadside pinout allows for easy board layout
- Guaranteed simultaneous switching noise level and dynamic threshold performance
- Guaranteed pin-to-pin output skew
- Separate control logic for each byte
- Extra data width for wider address/data paths or buses carrying parity
- Outputs source/sink 24 mA
- Additional specs for Multiple Output Switching
- Output loading specs for both 50 pF and 250 pF loads

Ordering Code:

Order Number	Package Number	Package Description	
74ACTQ18823SSC	MS56A	56-Lead Shrink Small Outline Package (SSOP), JEDEC MO-118, 0.300" Wide	;
74ACTQ18823MTD	MTD56	56-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 6.1m	m Wide

Device also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering code.

Logic Symbol

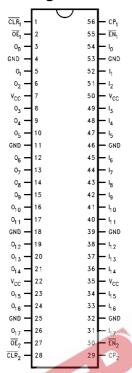


Pin Descriptions

Pin Names	Description
OE n	Output Enable Input (Active LOW)
CLR _n	Clear (Active LOW)
ĒN _n	Clock Enable (Active LOW)
CP _n	Clock Pulse Input
I ₀ -I ₁₇	Inputs
O ₀ -O ₁₇	Outputs

FACT™, Quiet Series™, FACT Quiet Series™, and GTO™ are trademarks of Fairchild Semiconductor Corporation

Connection Diagram



Functional Description

The ACTQ18823 consists of eighteen D-type edge-triggered flip-flops. These have 3-STATE outputs for bus systems organized with inputs and outputs on opposite sides. The device is byte controlled with each byte functioning identically, but independent of the other. The control pins can be shorted together to obtain full 16-bit operation. The following description applies to each byte. The buffered clock (CPn) and buffered Output Enable (OEn) are common to all flip-flops within that byte. The flip-flops will store the state of their individual D inputs that meet set-up and hold time requirements on the LOW-to-HIGH $\ensuremath{\mathsf{CP}}_{\ensuremath{\mathsf{n}}}$ transition. With \overline{OE}_n LOW, the contents of the flip-flops are available at the outputs. When $\overline{\text{OE}}_{n}$ is HIGH, the outputs go to the impedance state. Operation of the \overline{OE}_n input does not affect the state of the flip-flops. In addition to the Clock and Output Enable pins, there are Clear (CLRn) and Clock Enable (\overline{EN}_n) pins. These devices are ideal for parity bus interfacing in high performance systems.

When \overline{CLR}_n is LOW and \overline{OE}_n is LOW, the outputs are LOW. When \overline{CLR}_n is HIGH, data can be entered into the flip-flops. When $\overline{\text{EN}}_n$ is LOW, data on the inputs is transferred to the outputs on the LOW-to-HIGH clock transition. When the $\overline{\text{EN}}_n$ is HIGH, the outputs do not change state, regardless of the data or clock input transitions.

Function Table (Note 1)

		Inputs			Internal	Output	Fetia
OE	CLR	EN	СР	I _n	Q	O _n	Function
Н	Х	L	\	L	L	Z	High Z
Н	Х	L	~	Н	Н	Z	High Z
Н	L	X	X	X	L	Z	Clear
L	L	X	X	X	L	L	Clear
Н	Н	Н	X	Х	NC	Z	Hold
L	Н	Н	X	Х	NC	NC	Hold
Н	Н	L	~	L	L	Z	Load
Н	Н	L	~	Н	Н	Z	Load
L	Н	L	~	L	L	L	Load
L	Н	L	\	Н	Н	Н	Load

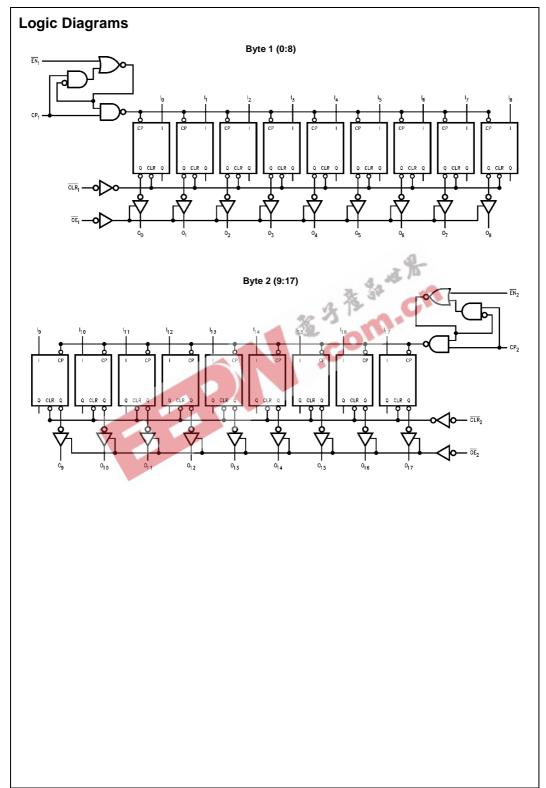
H= HIGH Voltage Level

Note 1: The table represents the logic for one byte. The two bytes are independent of each other and function identically.

L= LOW Voltage Level

X= Immaterial Z= High Impedance

 ^{∠=} LOW-to-HIGH Transition
 NC= No Change



Absolute Maximum Ratings(Note 2)

Supply Voltage (V $_{CC}$) -0.5V to +7.0V

DC Input Diode Current (I_{IK}) $V_I = -0.5V$

V_I = V_{CC} +0.5V +20 mA

DC Output Diode Current (I_{OK})

 $V_{\rm O} = -0.5 V$ $-20 \ mA$ $V_{\rm O} = V_{\rm CC} + 0.5 V$ $+20 \ mA$

DC Output Voltage (V_{O}) -0.5V to $V_{CC} + 0.5V$

DC Output Source/Sink Current (I_O) ± 50 mA

DC V_{CC} or Ground Current

Per Output Pin \pm 50 mA

Junction Temperature

PDIP/SOIC $+140^{\circ}\text{C}$ Storage Temperature -65°C to $+150^{\circ}\text{C}$

ESD Last Passing Voltage (Min)

Recommended Operating Conditions

 V_{IN} from 0.8V to 2.0V V_{CC} @ 4.5V, 5.5V

-20 mA

4000V

V() @ 4.5 V, 5.5 V

Note 2: Absolute maximum ratings are those values beyond which damage to the device may occur. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. Fairchild does not recommend operation of FACT™ circuits outside databook specifications.

DC Electrical Characteristics

Symbol	Parameter			+25°C	$T_A = -40^{\circ}C \text{ to } +85^{\circ}C$	Units	Conditions	
Cynibol	raianeter	(V)	(V) Typ Guaranteed Limits				00.141.1101.10	
V _{IH}	Minimum HIGH	4.5	1.5	2.0	2.0	V	V _{OUT} = 0.1V	
	Input Voltage	5.5	1.5	2.0	2.0	·	or V _{CC} –0.1V	
V _{IL}	Maximum LOW	4.5	1.5	0.8	0.8	V	V _{OUT} = 0.1V	
	Input Voltage	5.5	1.5	0.8	0.8	v	or V _{CC} –0.1V	
V _{OH}	Minimum HIGH	4.5	4.49	4.4	4.4	V	I _{OUT} = -50 μA	
	Output Voltage	5.5	5.49	5.4	5.4	· ·	100Τ = -30 μΑ	
							$V_{IN} = V_{IL}$ or V_{IH}	
		4.5		3.86	3.76	V	$I_{OH} = -24 \text{ mA}$	
		5.5		4.86	4.76		$I_{OH} = -24 \text{ mA (Note 3)}$	
V _{OL}	Maximum LOW	4.5	0.001	0.1	0.1	V	Ι _{ΟΙΙΤ} = 50 μΑ	
	Output Voltage	5.5	0.001	0.1	0.1	ľ	1001 – 30 μΑ	
							$V_{IN} = V_{IL}$ or V_{IH}	
		4.5		0.36	0.44	V	$I_{OL} = 24 \text{ mA}$	
		5.5		0.36	0.44		I _{OL} = 24 mA (Note 3)	
l _{OZ}	Maximum 3-STATE	5.5		±0.5	±5.0	μА	$V_I = V_{IL}, V_{IH}$	
	Leakage Current	0.0	0.0		±0.5	±5.0	po t	$V_O = V_{CC}$, GND
I _{IN}	Maximum Input Leakage Current	5.5		±0.1	±1.0	μΑ	$V_I = V_{CC}$, GND	
I _{CCT}	Maximum I _{CC} /Input	5.5	0.6		1.5	mA	$V_I = V_{CC} - 2.1V$	
I _{CC}	Maximum Quiescent Supply Current	5.5		8.0	80.0	μΑ	$V_{IN} = V_{CC}$ or GND	
I _{OLD}	Minimum Dynamic	5.5			75	mA	V _{OLD} = 1.65V Max	
I _{OHD}	Output Current (Note 4)	5.5			-75	mA	V _{OHD} = 3.85V Min	
V _{OLP}	Quiet Output Maximum Dynamic V _{OL}	5.0	0.5	0.8		V	(Note 6)(Note 7)	
V _{OLV}	Quiet Output Minimum Dynamic V _{OL}	5.0	-0.5	-0.8		V	(Note 6)(Note 7)	
V _{OHP}	Maximum Overshoot	5.0	V _{OH} + 1.0	V _{OH} + 1.5		V	(Note 5)(Note 7)	
V _{OHV}	Minimum V _{CC} Droop	5.0	V _{OH} – 1.0	V _{OH} – 1.8		V	(Note 5)(Note 7)	
V _{IHD}	Minimum High Voltage Level	5.0	1.7	2.0		V	(Note 5)(Note 8)	
V_{ILD}	Maximum Low Dynamic Input Voltage Level	5.0	1.2	1.2		V	(Note 5)(Note 8)	

Note 3: All outputs loaded; thresholds associated with output under test.

Note 4: Maximum test duration 2.0 ms, one output loaded at a time.

Note 5: Worst case package

Note 6: Maximum number of outputs that can switch simultaneously is n. (n - 1) outputs are switched LOW and one output held LOW.

 $\textbf{Note 7:} \ \textbf{Maximum number of outputs that can switch simultaneously is n. (n-1) outputs are switched HIGH and one output held HIGH.}$

Note 8: Maximum number of data inputs (n) switching. (n-1) input switching 0V to 3V. Input under test switching 3V to threshold (V_{ILD}) .

AC Electrical Characteristics

		V _{CC}		$T_A = +25^{\circ}C$		T _A = -40°	C to +85°C	
Symbol	Symbol Parameter		$C_L = 50 pF$			$C_L = 50 \text{ pF}$		Units
		(Note 9)	Min	Тур	Max	Min	Max	
f _{MAX}	Maximum Clock	5.0	100			90		MHz
	Frequency	3.0	100	100		90		IVITIZ
t _{PHL}	Propagation Delay	5.0	2.0		9.0	2.0	9.5	ns
t _{PLH}	CP _n to O _n		2.0		9.0	2.0	9.5	115
t _{PHL}	Propagation Delay	5.0	2.0		9.0	2.0	9.5	ns
	CLR _n to O _n	3.0	2.0		3.0	2.0	9.5	115
t _{PZL}	Output Enable Time	5.0	2.0		9.0	2.0	10.0	ns
t _{PZH}			2.0		9.0	2.0	10.0	115
t _{PLZ}	Output Disable Time	5.0	1.5		7.0	1.5	7.5	ns
t _{PHZ}			1.5		8.0	1.5	8.5	115

Note 9: Voltage Range 5.0 is 5.0V ± 0.5V.

AC Operating Requirements

		V _{CC}	T _A =	+25°C	$T_A = -40^{\circ}$ C to +85°C	
Symbol	Parameter	(V)	C _L =	50 pF 🚜 🏓	$C_L = 50 \text{ pF}$	Units
		(Note 10)	Тур	Guara	anteed Minimum	
t _S	Setup Time, HIGH or LOW, Input to Clock	5.0	36 3	3.0	3.0	ns
t _H	Hold Time, HIGH or LOW, Input to Clock	5.0	C	1.5	1.5	ns
t _S	Setup Time, HIGH or LOW, Enable to Clock	5.0	1	3.0	3.0	ns
t _H	Hold Time, HIGH or LOW, Enable to Clock	5.0		1.5	1.5	ns
t _W	CP _n Pulse Width, HIGH or LOW	5.0		4.0	4.0	ns
t _W	CLR _n Pulse Width, HIGH or LOW	5.0		4.0	4.0	ns
t _{REC}	Recovery Time, CLR _n to CP _n	5.0		6.0	6.0	ns

Note 10: Voltage Range 5.0 is $5.0V \pm 0.5V$.

Extended AC Electrical Characteristics

Symbol	Parameter		$T_A = -40^{\circ}\text{C to } +85^{\circ}\text{C}$ $V_{CC} = \text{Com}$ $C_L = 50 \text{ pF}$ 16 Outputs Switching (Note 12)		$T_A = -40$ °C to +85°C $V_{CC} = Com$ $C_L = 250$ pF (Note 13)		Units
		Min	Тур	Max	Min	Max	
t _{PLH}	Propagation Delay	5.2	6.5	7.6	7.0	9.8	
t _{PHL}	CP _n to O _n	5.3	6.5	7.8	6.8	10.0	ns
t _{PHL}	Propagation Delay CLR _n to O _n	4.8	5.3	6.2	5.2	7.5	ns
t _{PZH}	Output Enable Time	4.2	4.8	6.5	(Note 14)		ns
t _{PZL}		4.4	5.3	6.0			
t _{PHZ}	Output Disable Time	3.5	4.2	4.8	(Not	e 15)	ns
t _{PZL}		4.6	5.2	6.0	(INOI	e 13)	ns
t _{OSHL} (Note 11)	Pin to Pin Skew CP _n to O _n			1.0			ns
t _{OSLH} (Note 11)	Pin to Pin Skew CP _n to O _n			1.0	1 15		ns
t _{OSHL} (Note 11)	Pin to Pin Skew CLR _n to Output		a	1.0	CI		ns
t _{OST} (Note 11)	Pin to Pin Skew CP _n to Output		後力	1.5			ns

Note 11: Skew is defined as the absolute value of the difference between the actual propagation delays for any two separate outputs of the same device. The specification applies to any outputs switching HIGH-to-LOW (toSHL), LOW-to-HIGH (toSLH), or any combination switching LOW-to-HIGH and/or HIGH-to-LOW (toSHL)). to-LOW (t_{OST}).

Note 12: This specification is guaranteed but not tested. The limits apply to propagation delays for all paths described switching in phase (ii.e., all LOW-to-HIGH, HIGH-to-LOW, etc.).

Note 13: This specification is guaranteed but not tested. The limits represent propagation delays with 250 pF load capacitors in place of the 50 pF load capacitors in the standard AC load. This specification pertains to single output switching only.

Note 14: 3-STATE delays are load dominated and have been excluded from the datasheet.

Note 15: The Output Disable Time is dominated by the RC network (500 Ω , 250 pF) on the output and has been excluded from the datasheet.

Capacitance

Symbol	Parameter	Тур	Units	Conditions
C _{IN}	Input Pin Capacitance	4.5	pF	V _{CC} = 5.0V
C _{PD}	Power Dissipation Capacitance	95	pF	$V_{CC} = 5.0V$

FACT Noise Characteristics

The setup of a noise characteristics measurement is critical to the accuracy and repeatability of the tests. The following is a brief description of the setup used to measure the noise characteristics of FACT.

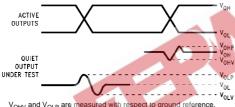
Equipment:

Hewlett Packard Model 8180A Word Generator PC-163A Test Fixture

Tektronics Model 7854 Oscilloscope

Procedure:

- Verify Test Fixture Loading: Standard Load 50 pF, 500Ω.
- Deskew the HFS generator so that no two channels have greater than 150 ps skew between them. This requires that the oscilloscope be deskewed first. It is important to deskew the HFS generator channels before testing. This will ensure that the outputs switch simultaneously.
- Terminate all inputs and outputs to ensure proper loading of the outputs and that the input levels are at the correct voltage.
- Set the HFS generator to toggle all but one output at a frequency of 1 MHz. Greater frequencies will increase DUT heating and affect the results of the measurement



 V_{OHV} and V_{OLP} are measured with respect to ground reference. Input pulses have the following characteristics: f = 1 MHz, $t_r = 3$ ns, $t_r = 3$ ns, skew < 150 ps.

FIGURE 1. Quiet Output Noise Voltage Waveforms

 Set the HFS generator input levels at 0V LOW and 3V HIGH for ACT devices and 0V LOW and 5V HIGH for AC devices. Verify levels with an oscilloscope.

V_{OLP}/V_{OLV} and V_{OHP}/V_{OHV} :

- Determine the quiet output pin that demonstrates the greatest noise levels. The worst case pin will usually be the furthest from the ground pin. Monitor the output voltages using a 50Ω coaxial cable plugged into a standard SMB type connector on the test fixture. Do not use an active FET probe.
- Measure V_{OLP} and V_{OLV} on the quiet output during the worst case transition for active and enable. Measure V_{OHP} and V_{OHV} on the quiet output during the worst case active and enable transition.
- Verify that the GND reference recorded on the oscilloscope has not drifted to ensure the accuracy and repeatability of the measurements.

V_{ILD} and $V_{\text{IHD}}\!:$

- Monitor one of the switching outputs using a 50Ω coaxial cable plugged into a standard SMB type connector on the test fixture. Do not use an active FET probe.
- First increase the input LOW voltage level, V_{IL}, until the output begins to oscillate or steps out a min of 2 ns. Oscillation is defined as noise on the output LOW level that exceeds V_{IL} limits, or on output HIGH levels that exceed V_{IH} limits. The input LOW voltage level at which oscillation occurs is defined as V_{ILD}.
- Next decrease the input HIGH voltage level, V_{IH}, until the output begins to oscillator steps out a min of 2 ns. Oscillation is defined as noise on the output LOW level that exceeds V_{IL} limits, or on output HIGH levels that exceed V_{IH} limits. The input HIGH voltage level at which oscillation occurs is defined as V_{IHD}.
- Verify that the GND reference recorded on the oscilloscope has not drifted to ensure the accuracy and repeatability of the measurements.

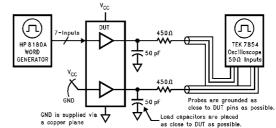
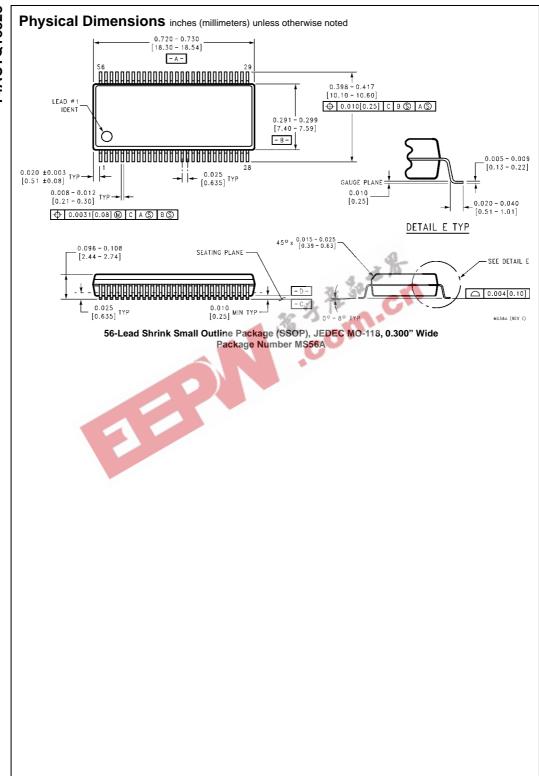
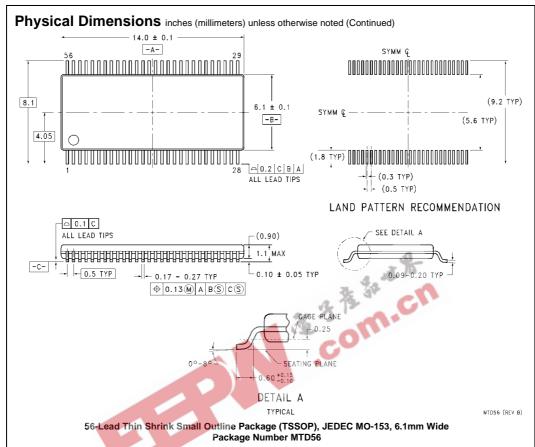


FIGURE 2. Simultaneous Switching Test Circuit





Fairchild does not assume any responsibility for use of any circuitry described, no circuit patent licenses are implied and Fairchild reserves the right at any time without notice to change said circuitry and specifications.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF THE PRESIDENT OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

9

- Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
- A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

www.fairchildsemi.com